Power MOSFET 20 V, 5.8 A/4.6 A Dual N-Channel, DFN6 3x3 mm Package Features

- Exposed Drain Package
- Excellent Thermal Resistance for Superior Heat Dissipation
- Low Threshold Levels
- Low Profile (< 1 mm) Allows It to Fit Easily into Extremely Thin Environments
- This is a Pb-Free Device

Applications

- DC-DC Converters (Buck and Boost Circuits)
- Power Supplies
- Hard Disk Drives

MOSFET I MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Param | Symbol | Value | Unit | | |
|---|-----------|-----------------------|-----------------------------------|---------------|----|
| Drain-to-Source Voltage | | | V _{DSS} | 20 | V |
| Gate-to-Source Voltag | е | | V _{GS} | ±20 | V |
| Continuous Drain | Steady | T _A = 25°C | I _D | 4.3 | А |
| Current (Note 1) | State | T _A = 85°C | | 3.0 | |
| | t ≤ 5.0 s | T _A = 25°C | | 5.8 | |
| Power Dissipation (Note 1) | | | P _D | 1.74 | W |
| Pulsed Drain Current t ≤10 μs | | | I _{DM} | 17.2 | А |
| Operating Junction and Storage Temperature | | | T _J , T _{STG} | -55 to 150 | °C |
| Source Current (Body Diode) | | | ۱ _S | 1.6 | Α |
| Lead Temperature for S (1/8" from case for 10 s | | urposes | ΤL | 260 | °C |

MOSFET II MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Param | Symbol | Value | Unit | | |
|--|------------------|-----------------------|-----------------------------------|---------------|----|
| Drain-to-Source Voltag | V _{DSS} | 20 | V | | |
| Gate-to-Source Voltag | е | | V _{GS} | ±12 | V |
| Continuous Drain | Steady | T _A = 25°C | I _D | 3.6 | А |
| Current (Note 1) | State | T _A = 85°C | | 2.5 | |
| | t ≤ 5.0 s | T _A = 25°C | | 4.6 | |
| Power Dissipation (Note 1) | Steady State | $T_A = 25^{\circ}C$ | P _D | 1.74 | W |
| Pulsed Drain Current t ≤10 μs | | | I _{DM} | 13.8 | А |
| Operating Junction and Storage Temperature | | | T _J , T _{STG} | -55 to 150 | °C |
| Source Current (Body Diode) | | | ا _S | 1.7 | А |
| Lead Temperature for S (1/8" from case for 10 s | | urposes | ΤL | 260 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm², 1 oz. Cu



ON Semiconductor®

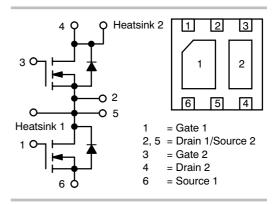
http://onsemi.com

MOSFET I

| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 20 V | 60 mΩ @ 4.5 V | 5.8 A |

MOSFET II

| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 20 V | 90 mΩ @ 4.5 V | 4.6 A |



DIAGRAMS DFN6 CASE 506AG $1 \begin{bmatrix} \circ & 3502 \\ AYWW \\ \bullet \end{bmatrix}$ 3502 = Specific Device Code A = Assembly Location Y = Year WW = Work Week $\bullet = Pb-Free Package$

MARKING

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|---------------|-------------------|-----------------------|
| NTLGD3502NT1G | DFN6 (Pb-free) | 3000/Tape & Reel |
| NTLGD3502NT2G | DFN6 (Pb-free) | 3000/Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Max | Unit |
|--|----------------|-----|------|
| Junction-to-Ambient – Steady State (Note 1) | $R_{	heta JA}$ | 72 | °C/W |
| Junction-to-Ambient – t \leq 5 s (Note 1) | $R_{	hetaJA}$ | 40 | |
| Junction-to-Ambient – Steady State min Pad (Note 2) | $R_{	heta JA}$ | 110 | |
| Junction-to-Ambient – Pulsed (25% duty cycle) min Pad (Note 2) | $R_{	hetaJA}$ | 60 | |

MOSFET I ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

| Parameter | Symbol | Test Conditio | ons | Min | Тур | Max | Unit |
|--|--------------------------------------|---|------------------------|-----|------|------|-------|
| Off Characteristics | - | - | | | - | - | - |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I _D = 250 μ A | | 20 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | I _D = 250 μA, ref to | o 25°C | | 10 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V_{GS} = 0 V, V_{DS} = 16 V | $T_J = 25^{\circ}C$ | | | 1.0 | μΑ |
| | | | T _J = 125°C | | | 10 | |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} = | ±20 V | | | ±100 | nA |
| On Characteristics (Note 3) | | • | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D = 2$ | 250 μA | 1.0 | 1.7 | 2.0 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -4.4 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 4.5 V, I _D = | = 4.3 A | | 50 | 60 | mΩ |
| Forward Transconductance | 9 _{FS} | V _{DS} = 10 V, I _D = | 4.0 A | | 5.9 | | S |
| Charges, Capacitances & Gate Resi | stance | • | | | | | |
| Input Capacitance | C _{ISS} | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 10 V | | | 250 | 480 | pF |
| Output Capacitance | C _{OSS} | | | | 138 | 200 | - |
| Reverse Transfer Capacitance | C _{RSS} | | | | 52 | 90 | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 4.5 V, V _{DS} = 10 V; I _D = 4.3 A (Note 3) | | | 2.9 | 4.0 | nC |
| Gate-to-Source Charge | Q _{GS} | | | | 1.0 | | - |
| Gate-to-Drain Charge | Q _{GD} | | | | 1.1 | | |
| Gate Resistance | R _G | | | | 1.5 | | Ω |
| Switching Characteristics, V _{GS} = 4.5 | V (Note 4) | • | | | | | |
| Turn-On Delay Time | t _{d(ON)} | V_{GS} = 4.5 V, V_{DD} | | | 7.0 | 12 | ns |
| Rise Time | t _r | I _D = 4.3 A, R _G = | 10 Ω | | 17.5 | 25 | 1 |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 8.6 | 15 | 1 |
| Fall Time | t _f | | | | 3.3 | 5.0 | 1 |
| Drain-Source Diode Characteristics | - | | | | | - | - |
| Forward Diode Voltage | V _{SD} | V_{GS} = 0 V, I_{S} = 1.6 A | $T_J = 25^{\circ}C$ | | 0.78 | 1.2 | V |
| | | | T _J = 125°C | | 0.63 | | 1 |
| Reverse Recovery Time | t _{RR} | $V_{GS} = 0 V, d_{ISD}/d_t =$ | 100 A/μs, | | 16.7 | | ns |
| Charge Time | t _a | I _S = 1.0 A | | | 8.2 | | 1 |
| Discharge Time | t _b | | | | | | 1 |

Reverse Recovery Charge

 $\mathsf{Q}_{\mathsf{R}\mathsf{R}}$

7.0

nC

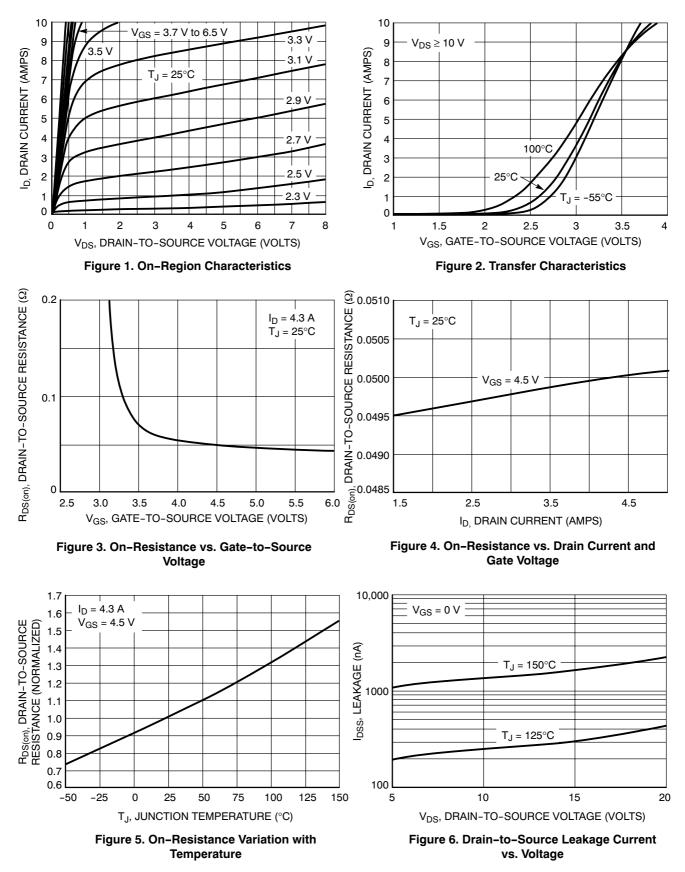
MOSFET II ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

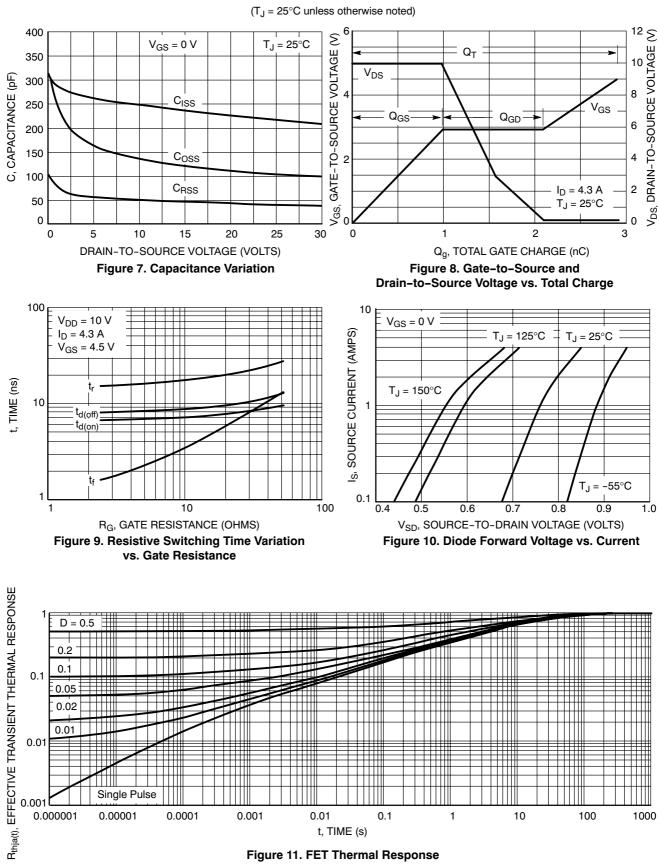
| Parameter | Symbol | Test Condition | ons | Min | Тур | Max | Unit |
|--|--------------------------------------|---|---|-----|------|---------|-------|
| Off Characteristics | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I _D = 250 μ A | | 20 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | I _D = 250 μA, ref t | o 25°C | | 22 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, V _{DS} = 16 V | T _J = 25°C T _J = 125°C | | | 1 10 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} = | ±12 V | | | ±100 | nA |
| On Characteristics (Note 5) | | | | | | 1 | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | 250 μA | 0.6 | | 2.0 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -2.8 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 4.5 V, I _D = | = 3.4 A | | 70 | 90 | mΩ |
| | | V _{GS} = 2.5 V, I _D = | = 1.7 A | | 95 | 120 | |
| Forward Transconductance | 9 _{FS} | V _{DS} = 10 V, I _D = | = 3.4 A | | 6.7 | | S |
| Charges, Capacitances & Gate Resi | stance | | | | | | |
| Input Capacitance | C _{ISS} | V_{GS} = 0 V, f = 1 MHz, V_{DS} = 10 V | | | 144 | 275 | pF |
| Output Capacitance | C _{OSS} | | | | 67 | 125 | |
| Reverse Transfer Capacitance | C _{RSS} | | | | 22 | 40 | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 4.5 V, V _{DS} = 10 | V; I _D = 3.4 A | | 2.1 | 5.0 | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 0.11 | | |
| Gate-to-Source Charge | Q _{GS} | | | | 0.42 | | |
| Gate-to-Drain Charge | Q _{GD} | 1 1 | | | 0.7 | | |
| Switching Characteristics, V _{GS} = 4.5 | V (Note 6) | • | | | • | | |
| Turn-On Delay Time | t _{d(ON)} | V _{GS} = 4.5 V, V _{DD} | = 16 V, | | 4.8 | 10 | ns |
| Rise Time | t _r | I _D = 3.4 A, R _G = | 10 Ω | | 13.6 | 25 | |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 9.0 | 20 | |
| Fall Time | t _f | | | | 1.9 | 5.0 | |
| Drain-Source Diode Characteristics | ; | • | | | • | | |
| Forward Diode Voltage | V _{SD} | V_{GS} = 0 V, I_{S} = 1.7 A | $T_J = 25^{\circ}C$ | | 0.8 | 1.15 | V |
| | | | T _J = 150°C | | 0.63 | | 1 |
| Reverse Recovery Time | t _{RR} | $V_{GS} = 0 V, d_{ISD}/d_t =$ | 100 A/μs, | | 12 | | ns |
| Charge Time | ta | I _S = 1.0 A | | | 8.0 | | 1 |
| Discharge Time | t _b | | | | 4.0 | | 1 |
| Reverse Recovery Charge | Q _{RR} | | | | 5.0 | | nC |

5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2% 6. Switching characteristics are independent of operating junction temperatures

TYPICAL MOSFET I N-CHANNEL PERFORMANCE CURVES

(T_J = 25° C unless otherwise noted)

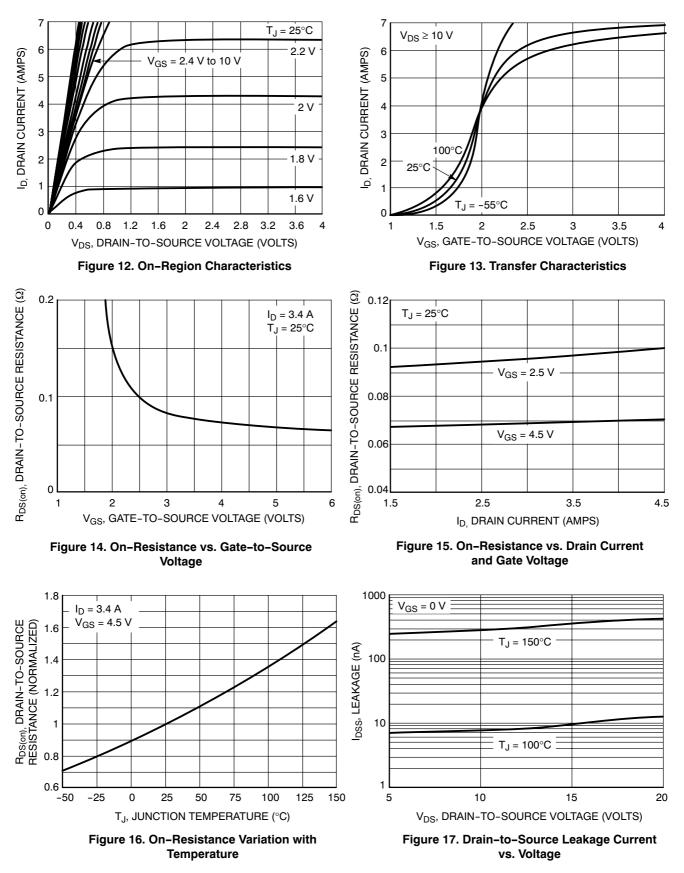


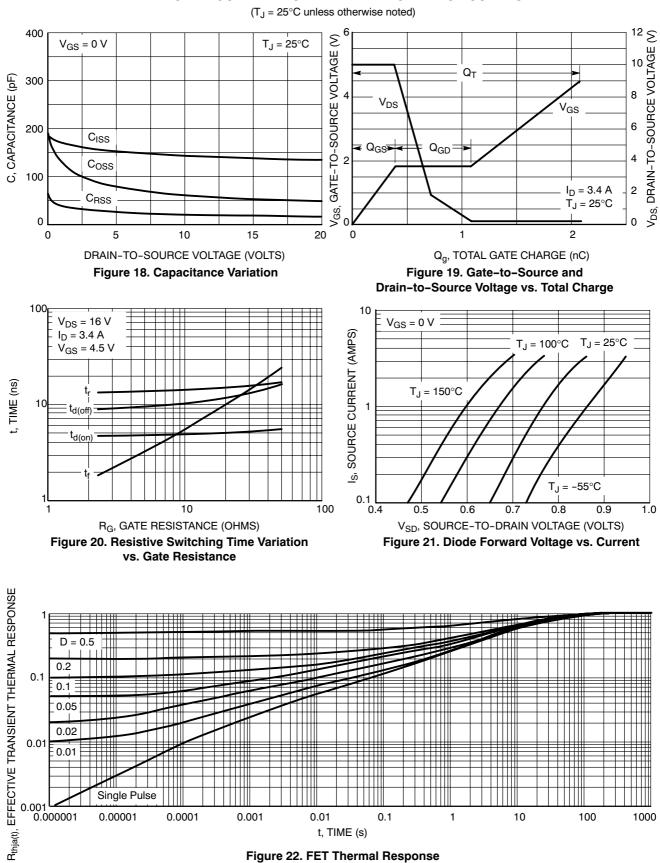


TYPICAL MOSFET I N-CHANNEL PERFORMANCE CURVES

TYPICAL MOSFET II N-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

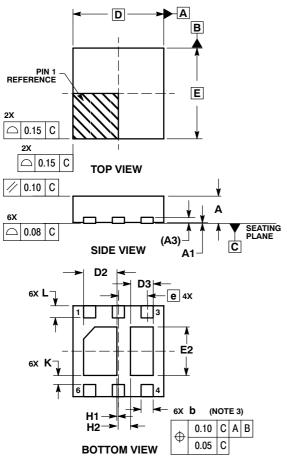




TYPICAL MOSFET II N-CHANNEL PERFORMANCE CURVES

PACKAGE DIMENSIONS

DFN6 3*3 MM, 0.95 PITCH CASE 506AG-01 ISSUE O

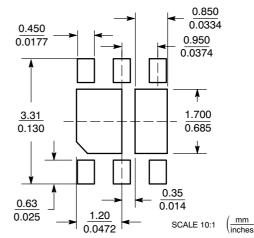


NOTES

- DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMESNION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30
- AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL. 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| | MILLIMETERS | | | |
|-----|-------------|---------|------|--|
| DIM | MIN | NOM | MAX | |
| Α | 0.80 | 0.90 | 1.00 | |
| A1 | 0.00 | 0.03 | 0.05 | |
| A3 | 0 | .20 REF | | |
| b | 0.35 | 0.40 | 0.45 | |
| D | 3 | .00 BSC | ; | |
| D2 | 1.00 | 1.10 | 1.20 | |
| D3 | 0.65 | 0.75 | 0.85 | |
| Е | 3.00 BSC | | | |
| E2 | 1.50 | 1.60 | 1.70 | |
| е | 0 | .95 BSC | ; | |
| К | 0.21 | | | |
| L | 0.30 | 0.40 | 0.50 | |
| H1 | 0.05 REF | | | |
| H2 | 0 | .40 REF | | |

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and use registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use payes that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5773-3850 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

ON Semiconductor: <u>NTLGF3501NT2G</u> <u>NTLGD3502NT2G</u>